

## SANYO Semiconductors DATA SHEET

An ON Semiconductor Company

N-Channel Silicon MOSFET (Dual Gate)

# **3SK263** — FM Tuner, VHF Tuner, High-Frequency Amplifier Applications

#### **Features**

- · Enhancement type
- · Small noise figure
- · Small cross modulation

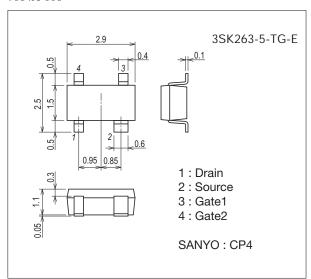
#### **Specifications**

#### Absolute Maximum Ratings at Ta=25°C

Parameter	Symbol	Conditions	Ratings	Unit
Drain-to-Source Voltage	V <sub>DS</sub>		15	V
Gate1-to-Source Voltage	V <sub>G</sub> 1S		±8	V
Gate2-to-Source Voltage	V <sub>G2S</sub>		±8	V
Drain Current	ID		30	mA
Allowable Power Dissipation	PD		200	mW
Channel Temperature	Tch		125	°C
Storage Temperature	Tstg		-55 to +125	°C

#### **Package Dimensions**

unit : mm (typ) 7014A-006



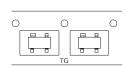
#### **Product & Package Information**

• Package : CP4

• JEITA, JEDEC : SC-61, SC-82AB, SOT-143, SOT-343

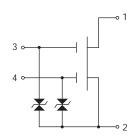
• Minimum Packing Quantity: 3,000 pcs./reel

#### Packing Type: TG



Marking

#### **Electrical Connection**



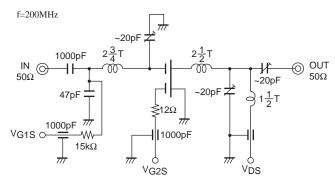
#### Electrical Characteristics at Ta=25°C

Parameter	Symbol	Conditions	Ratings			Unit	
Parameter	Parameter Symbol Conditions		min	typ	max	Utill	
Drain-to-Source Voltage	VDS	VG1S=0V, VG2S=0V, ID=100μA	15			V	
Gate1-to-Source Cutoff Voltage	V <sub>G1S</sub> (off)	V <sub>DS</sub> =6V, V <sub>G2S</sub> =4V, I <sub>D</sub> =100μA	0	0.7	1.3	V	
Gate2-to-Source Cutoff Voltage	V <sub>G2S</sub> (off)	V <sub>DS</sub> =6V, V <sub>G1S</sub> =3V, I <sub>D</sub> =100μA	0.1	0.9	1.6	V	
Gate1-to-Source Leakage Current	I <sub>G1SS</sub>	V <sub>G1S</sub> =±6V, V <sub>G2S</sub> =V <sub>DS</sub> =0V			±50	nA	
Gate2-to-Source Leakage Current	IG2SS	VG2S=±6V, VG1S=VDS=0V			±50	nA	
Zero-Gate Voltage Drain Current	I <sub>DSX</sub>	V <sub>DS</sub> =6V, V <sub>G1S</sub> =1.5V, V <sub>G2S</sub> =4V	2.5*		24*	mA	
Forward Transfer Admittance	yfs	V <sub>DS</sub> =6V, I <sub>D</sub> =10mA, V <sub>G2S</sub> =4V, f=1kHz		14		mS	
Input Capacitance	Ciss	Vpc 6V f 1MHz Voto 0V Voco 4V		2.7		pF	
Reverse Transfer Capacitance	Crss	V <sub>DS</sub> =6V, f=1MHz, V <sub>G1S</sub> =0V, V <sub>G2S</sub> =4V		0.015	0.03	pF	
Power Gain	PG	V <sub>DS</sub> =6V, I <sub>D</sub> =10mA, V <sub>G2S</sub> =4V, f=200MHz	18	21		dB	
Noise Figure	NF	V <sub>DS</sub> =6V, I <sub>D</sub> =10mA, V <sub>G2S</sub> =4V, f=200MHz		1.1	2.2	dB	

#### $^{\star}$ : The 3SK263 is classified by IDSX as follows : (unit : mA)

Rank	4	5	6	
IDSX	2.5 to 6.0	5.0 to 12.0	10.0 to 24.0	

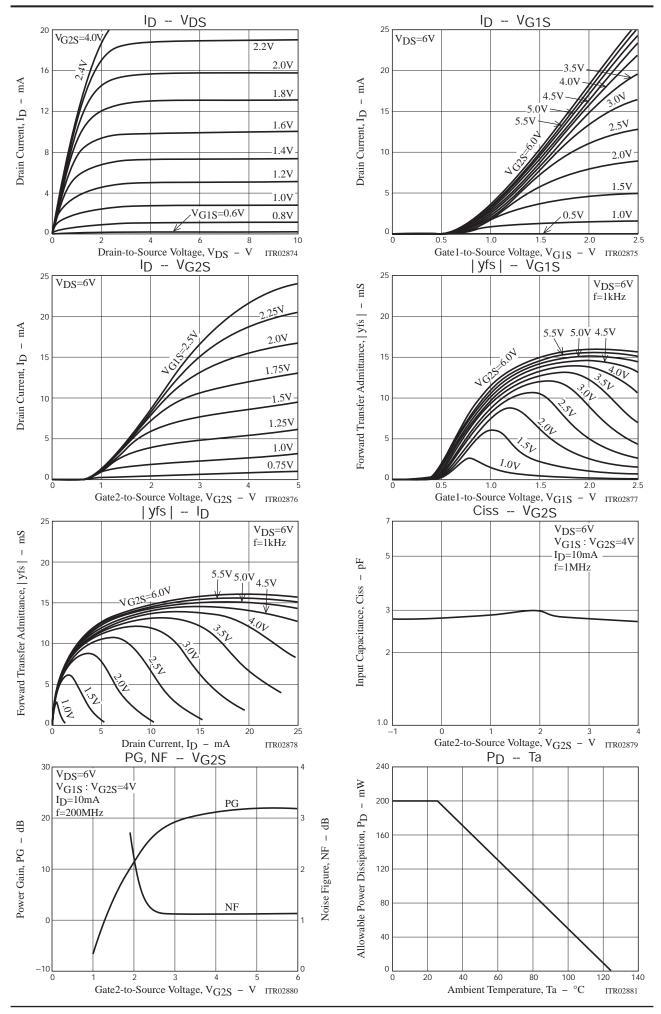
#### PG, NF Specified Test Circult



 $L:1mm \not O \ enamel \ wire \ 10mm \not O$ 

#### **Ordering Information**

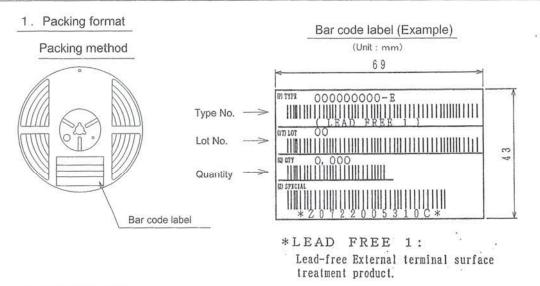
Device	Package	Shipping	memo	
3SK263-5-TG-E	CP4	3,000pcs./reel	Pb Free	



#### **Embossed Taping Specification**

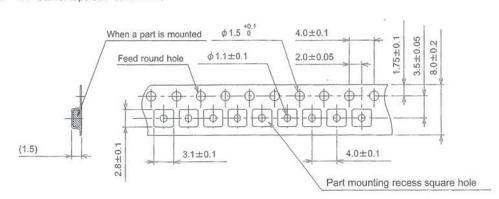
#### 3SK263-5-TG-E

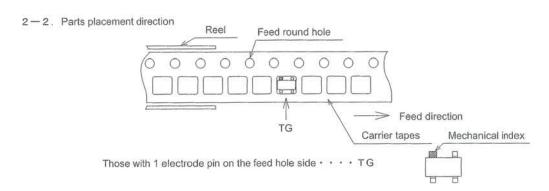
Storage package Outline name Carrier tape Type number	Maximum Number of devices contained (pcs.)			Packing format		
	Type number	Reel	Inner box	Outer box	Inner box BOX (C-1)	Outer box BOX (A-7)
CP4	CP4	3,000	15,000	90,000	5 reels contained Dimensions:mm(external) 1 8 3 × 7 2 × 1 8 5	6 inner boxes contained Dimensions:mm(external) 4 4 0 × 1 9 5 × 2 1 0



#### 2. Taping structure

#### 2-1. Carrier tape size (Unit : mm)



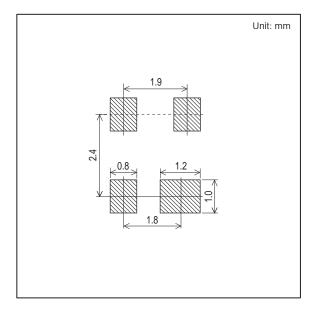


#### **Outline Drawing**

3SK263-5-TG-E

### Mass (g) Unit 0.013 For reference mm 2. 9±0. 15 0. 4<sup>+0. 1</sup><sub>-0. 05</sub> 0. 1<sup>+0. 1</sup> 0. 5+0. 25 3 1. 5±0. 15 2. 5±0. 2 0. 6<sup>+0. 1</sup> 2 0.95 0.85 0. 3±0.1 1. 1±0.15 0.1 \$ \*1:Lot indication

#### Land Pattern Example



Note on usage: Since the 3SK263 is a MOSFET product, please avoid using this device in the vicinity of highly charged objects.

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